Prospects and requirements for measurement of the distribution of the elements with XEUS

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Overview

- General considerations
- Coronal abundances
- Clusters of Galaxies
- The WHIM
- Active Galactic Nuclei
- Conclusions

General considerations

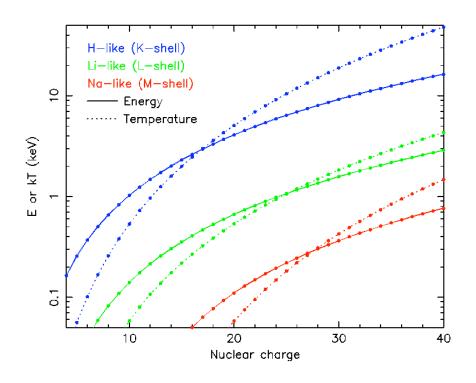
 In order to detect any emission/absorption line (equivalent width EW) with signal to noise ratio S and spectral resolution _E one needs at least N_i line counts with:

$$N_1 > S^2(1 + E/EW)$$

Conclusion: optimal resolution if _E<EW of measured line

Temperature sensitivity

 Determining abundances depends on plasma (T) structure; for each element, different ions for different T-ranges



Rare elements

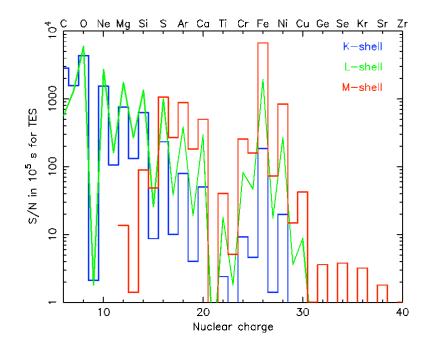
K-shell

- Plots: maximum EW
 (as function of T) of
 lines for CIE plasma;
 solar abundances
- Lines with low EW need good:
- 1. Eff. area calibration
- 2. plasma diagnostics
- 3. atomic physics
- 4. bright sources



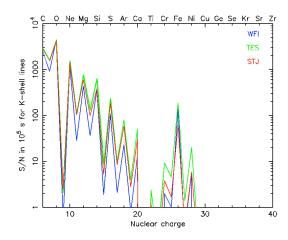
Coronal abundances

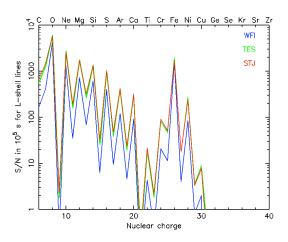
- Plot for CIE plasma with emission measure 6x10⁵⁹ m⁻³ at d=50 pc (as in AR Lac)
- S/N calculated for T at peak line emission
- Shown are results for 10⁵ s with TES



Comparison between instruments

- Abundant elements (like Fe) do not require high resolution (in bright sources)
- Rare elements (like Na, Al, P) better seen with high resolution





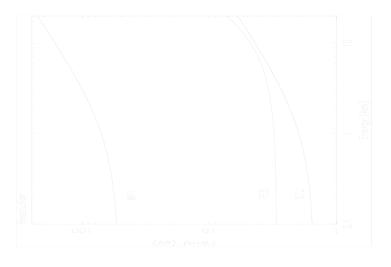
Example: Na in coronal spectrum

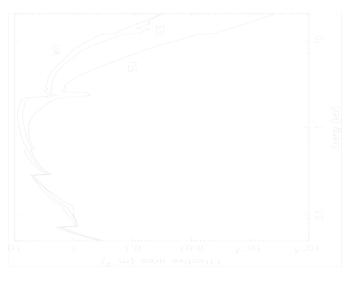
- Needs to find weak lines in crowded spectral area
- High spectral resolution not only required for sensitivity but also for deblending



Effective area and spectral resolution

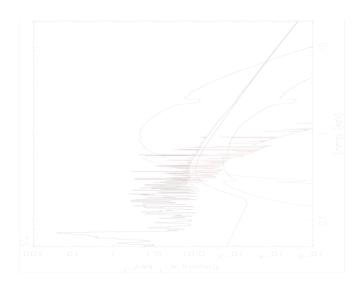
- _E and area from XEUS SRD draft
- Abundance determination: needs both high resolution (seeing the lines) and area (getting the photons)

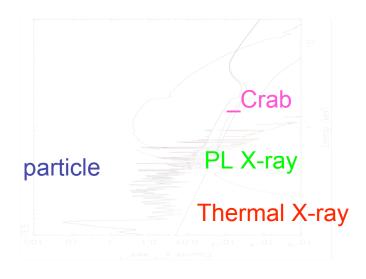


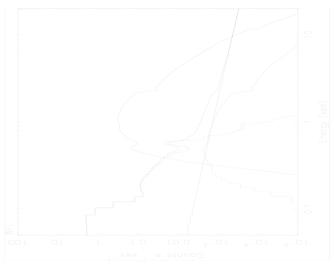


Background limitations for weak sources

Background is of serious concern for weak sources: both at Fe-K and at low E

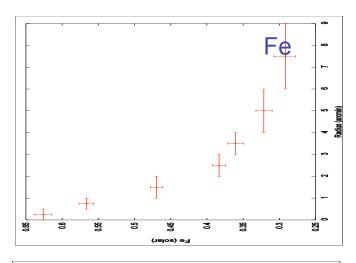


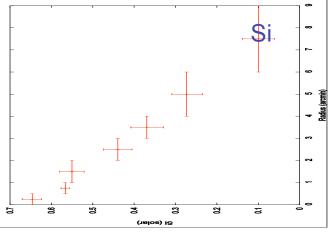




Clusters of galaxies: XMM

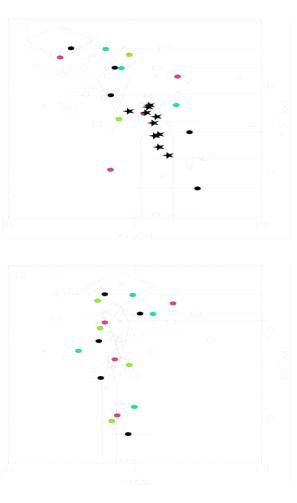
- Example: 130 ks of 2A 0335+096 with XMM-Newton
- Allows to determine radial profiles for Fe, Si, S, ...





Radial distribution

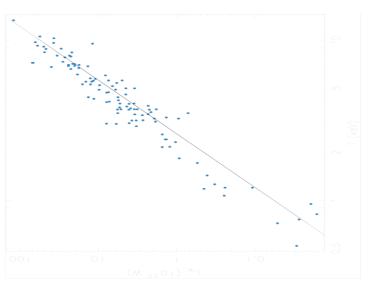
- Different behaviour of O/Fe and Si/Fe in clusters; what evolution?
- Different history type
 Ia and type II SNe
- Fe "inert" i.e. diffusion scale is small

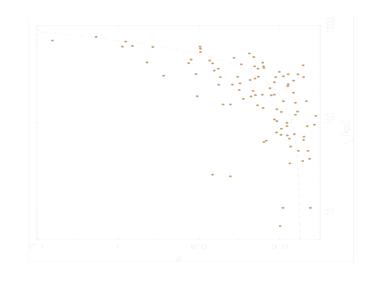


Tamura et al. 2003

Modeling of clusters

- Use scaling laws (here based on Reiprich & Böhringer 2002)
- Use simple evolution, for fixed T:
- $r_c \sim (1+z)^{-5/6}$
- $L \sim (1+z)^{1.5}$
- $M_{gas} \sim (1+z)^{-0.5}$

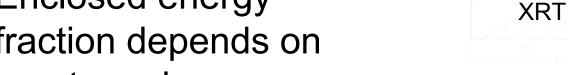




Sizes and apertures

HEW

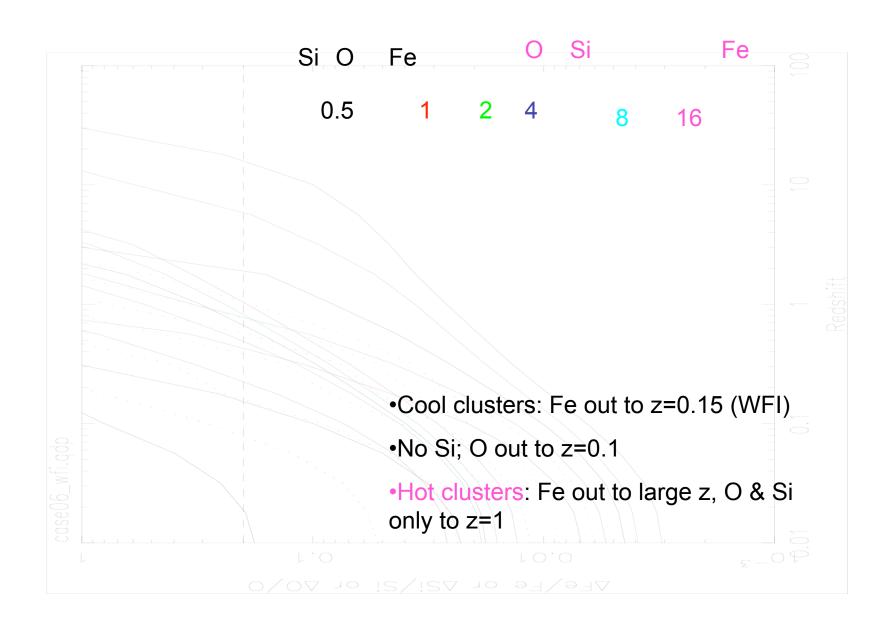
- Angular size core radius ~constant for large z
- Enclosed energy fraction depends on aperture size:



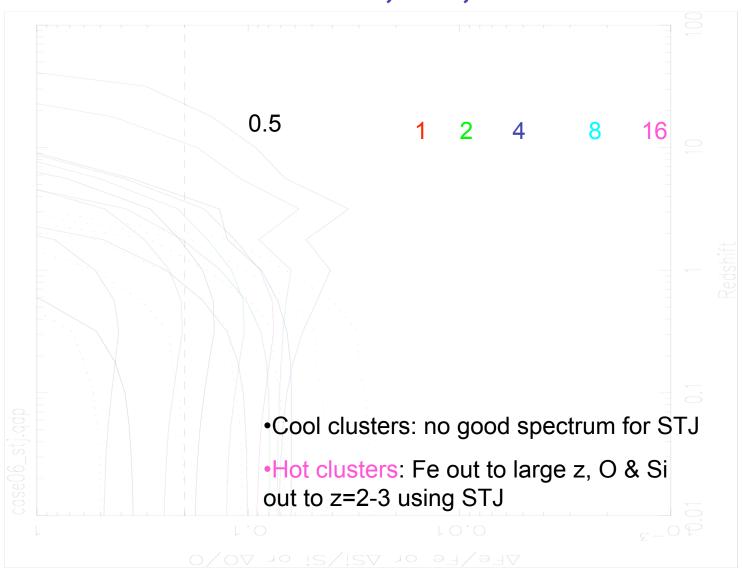


- TES 0.45 arcmin-
- STJ 0.15 arcmin

Abundances of Fe, Si, O in clusters

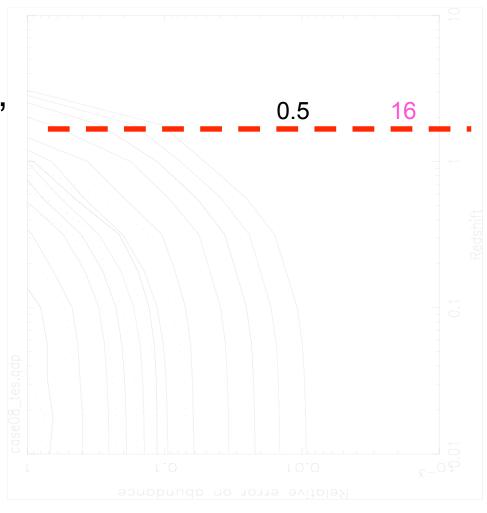


Abundances of Fe, Si, O in clusters



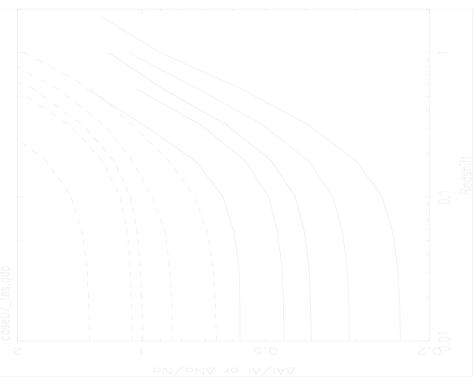
The CNO elements in clusters

- CNO best done using TES (STJ small FOV), WFI poor resolution (C,N lines only 1% above continuum)
- O (thick solid)
- N (thin solid)
- C (dotted)



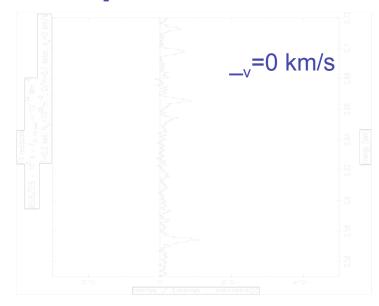
Rare elements in clusters

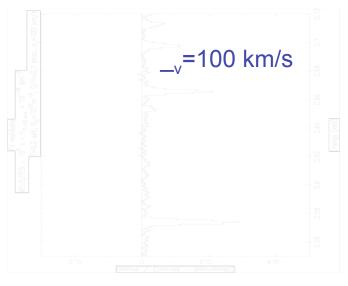
- Example: Na (dashed) and Al (solid)
- Hard to detect, out to z~0.3 for hot clusters with TES
- Impossible with STJ (field of view) or WFI (spectral resolution)



WHIM: narrow absorption lines

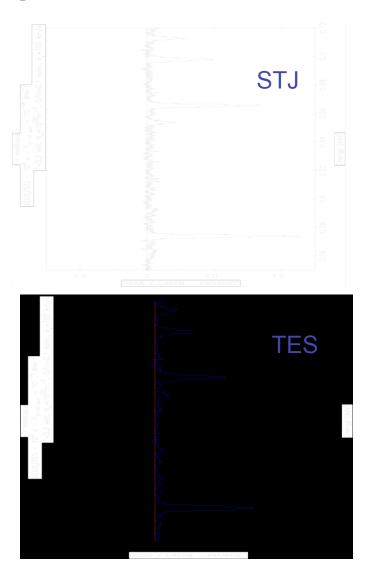
- Simulations for source with 2-10 keV flux of 10⁻¹⁴ W/m²
- $N_H = 10^{25} \text{ m}^{-2}$
- O/H = 0.1 solar
- kT=0.2 keV
- \ _v important





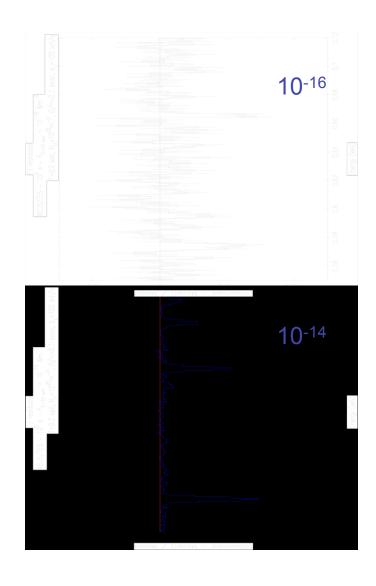
WHIM absorption: spectral resolution

- Simulations for source with 2-10 keV flux of 10⁻¹⁴ W/m²
- $N_H = 10^{25} \text{ m}^{-2}$
- O/H = 0.1 solar
- kT=0.2 keV
- spectral resolution important



WHIM absorption: sensitivity

- Simulations for source with 2-10 keV flux of 10⁻¹⁶ or 10⁻¹⁴ W/m²
- There are 11 sources per _° >10-16 W/m² \ ideal for mapping
- Further as before
- need both large area & high res.



WHIM absorption: final remarks

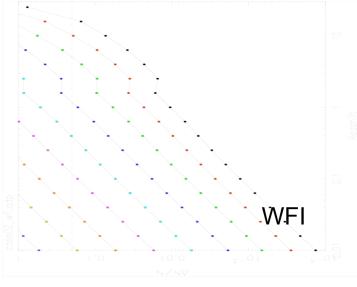
- Absolute abundances (wrt H) extremely hard to get unless also Ly_ etc. measurements available
- Also relative abundances hard to get: needs to determine T, _v simultaneously with abundances

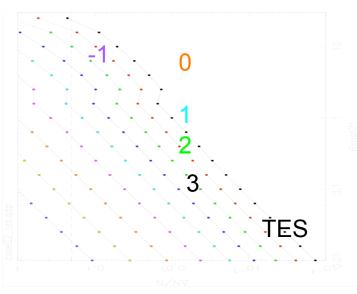
Using Fe-K emission lines in AGN as abundance tracers

- Fe-K can serve as abundance tracer
- Both narrow and broad lines can be used
- But be aware of model-dependent effects:
- 1. Jet synchrotron emission
- 2. Accretion disk modeling
- 3. Narrow/Broad line region modeling

Detecting a narrow Fe-K line

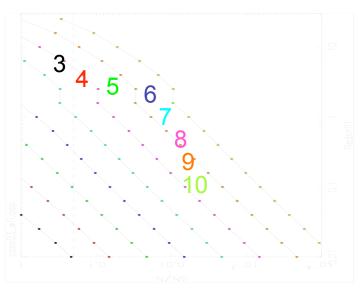
- Simulation for 10⁸
 Msun source at L_{EDD}
 (2.5x10³⁸ W in 2-10 keV band)
- Lines with log EW (eV) between -1 and 3
- high resolution allows detection out to larger z

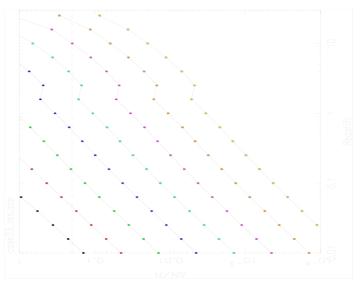




Narrow lines for different L

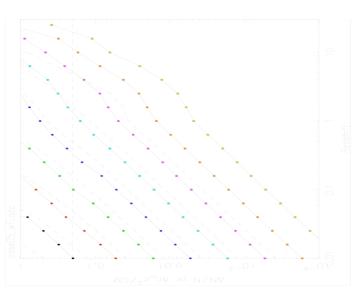
- Take a narrow line with EW = 100 eV
- Simulations for BH mass of 10³-10¹⁰
 Msun

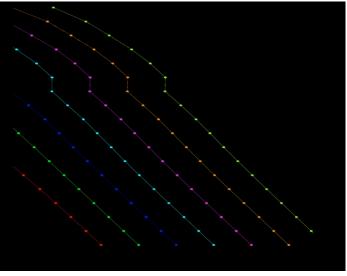




Detecting broad Fe-K lines

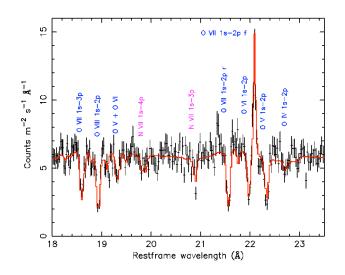
Broad Fe-K lines
 (above) similar to
 narrow Fe-K lines
 (below), for WFI

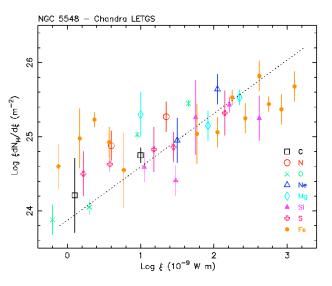




Using warm absorbers as abundance tracers

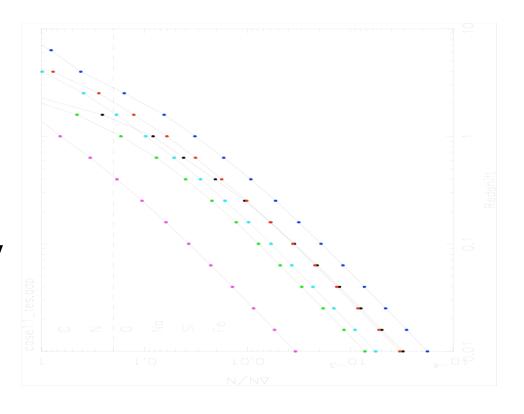
- About 50 % of Seyferts have warm absorber
- Many ions available, not just Fe





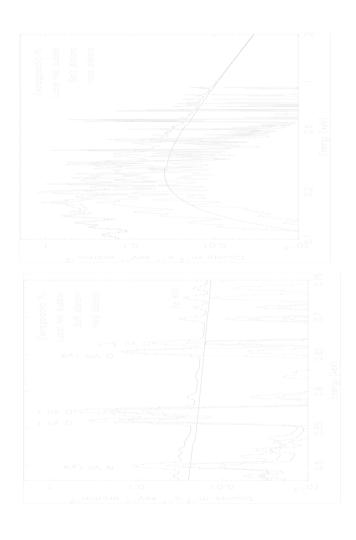
Feasibility of abundance measurements in warm absorbers

- Power law for 10⁸
 Msun source at L_{EDD}
 (2.5x10³⁸ W in 2-10 keV band)
- Warm absorber as in NGC 5548
- Abundances of many elements out to z=1
- Improves for higher spectral resolution



X-ray background

- X-ray background rich in structure
- Affects all observations of dim sources (in particular extended sources)
- Need to understand it
- Useful for study of diffuse Galactic abundances



Grand summary of requirements for abundance studies

 In order to detect any emission/absorption line (equivalent width EW) with signal to noise ratio S and spectral resolution _E one needs at least N_i line counts with:

$$N_I > S^2(1 + E/EV)$$

With here:
 $EW = (F_c + F_{back}) / F_I$

Optimalization of instrument

The following needs to be maximized:

	Extended	Point
Strong line EW>>_E	At_	At
Weak line EW<<_E	At_ / _E	At / _E

Conclusion

- For evolution studies of abundances, needs in particular at low E:
- high throughput (A),
- high spectral resolution (small _E, 1 eV or less)
- For extended sources, sufficient FOV (at least 1 arcmin size)